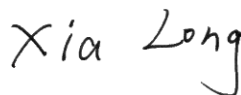


TEST REPORT

Applicant: Shenzhen CHT Technology Co., Ltd.
Address: 102, Building B2, Building L, Sheng Guang Industrial Area, No.152 Dong Huan Road, Xin Qiao Street, Bao'An District, 518125 Shenzhen, Guangdong Sheng, China
Equipment Type: Wireless Controller
Model Name: SP5251
Brand Name: N/A
Test Standard: IEEE Std 149-2021
Sample Arrival Date: Jan. 31, 2024
Test Date: Feb. 01, 2024
Date of Issue: Feb. 19, 2024

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

Tested by: Mai Jintian**Checked by:** Xia Long**Approved by:** Tolan Tu
(Testing Director)

Revision History

Version	Issue Date	Revisions
<u>Rev. 01</u>	<u>Feb. 19, 2024</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	☒ Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	☐ 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Shenzhen CHT Technology Co., Ltd.
Address	102, Building B2, Building L, Sheng Guang Industrial Area, No.152 Dong Huan Road, Xin Qiao Street, Bao'An District, 518125 Shenzhen, Guangdong Sheng, China

2.2 Manufacturer Information

Manufacturer	Shenzhen CHT Technology Co., Ltd.
Address	102, Building B2, Building L, Sheng Guang Industrial Area, No.152 Dong Huan Road, Xin Qiao Street, Bao'An District, 518125 Shenzhen, Guangdong Sheng, China

2.3 General Description for Equipment under Test (EUT)

EUT Name	Wireless Controller
Model Name Under Test	SP5251
Antenna Type	PCB Antenna
Dimensions	9.5*5.5 mm

2.4 Ancillary Equipment

Note: Not applicable.

2.5 Technical Information

Test Frequencies	2400MHz, 2410MHz, 2420MHz, 2430MHz, 2440MHz, 2450MHz, 2460MHz, 2470MHz, 2480MHz, 2490MHz, 2500MHz
------------------	--

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	IEEE Std 149-2021	IEEE Standard Test Procedures for Antennas

3.2 Test Verdict

Report Section	Description	Remark
ANNEX A.1	Gain and Efficiency	--
ANNEX A.2	VSWR	--
ANNEX B	Radiation Pattern	--

3.3 Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Item	Uncertainty
Gain	$\pm 1.92\text{dB}$
VSWR(S11)	± 0.61

4 GENERAL TEST CONFIGURATIONS

4.1 Test Condition

Environment Parameter	Selected Values During Tests			
	Ambient Pressure (KPa)	Temperature (°C)	Voltage	Relative Humidity (%)
Normal Temperature, Normal Voltage (NTNV)	101	21.4	N/A	41

4.2 Test Equipment List

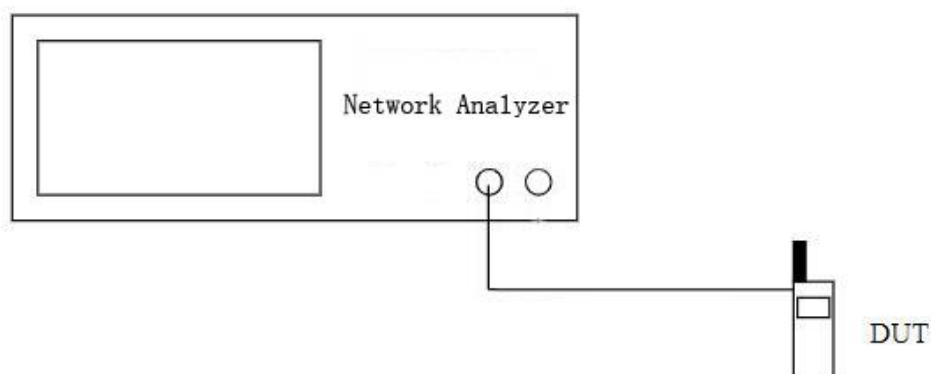
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
SG24 Multi-probe Antenna Measurement System	SATIMO	SG24-L	1101855- 0001	2021.11.12	2024.11.11
Vector Network Analyzer	Agilent	E5071B	MY42404001	2024.01.16	2025.01.15
Description	Manufacturer	Name		Version	
Test Software	MVG	SPM		V 1.8	

4.3 Test Setup

4.3.1 Antenna gain, efficiency and radiation pattern test setup



4.3.2 S11 parameter test setup



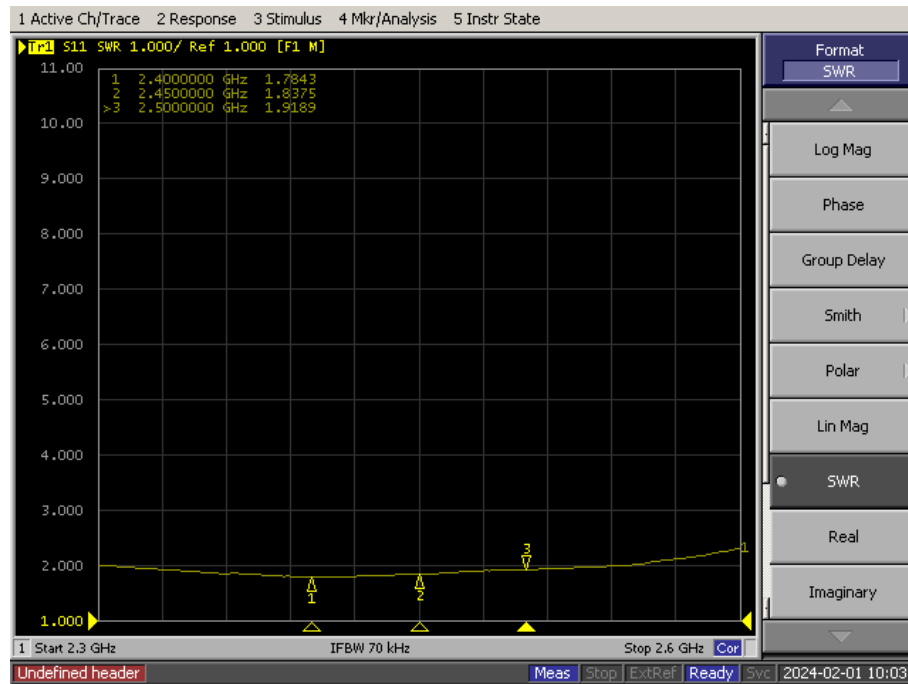
ANNEX A TEST RESULTS

A.1 Gain and Efficiency

Frequency	Gain (dBi)	Efficiency (%)
2400MHz	0.78	43
2410MHz	0.83	43
2420MHz	0.86	42
2430MHz	0.82	43
2440MHz	0.90	42
2450MHz	1.01	42
2460MHz	0.99	41
2470MHz	0.83	42
2480MHz	0.91	42
2490MHz	1.08	41
2500MHz	1.08	41

A.2 VSWR

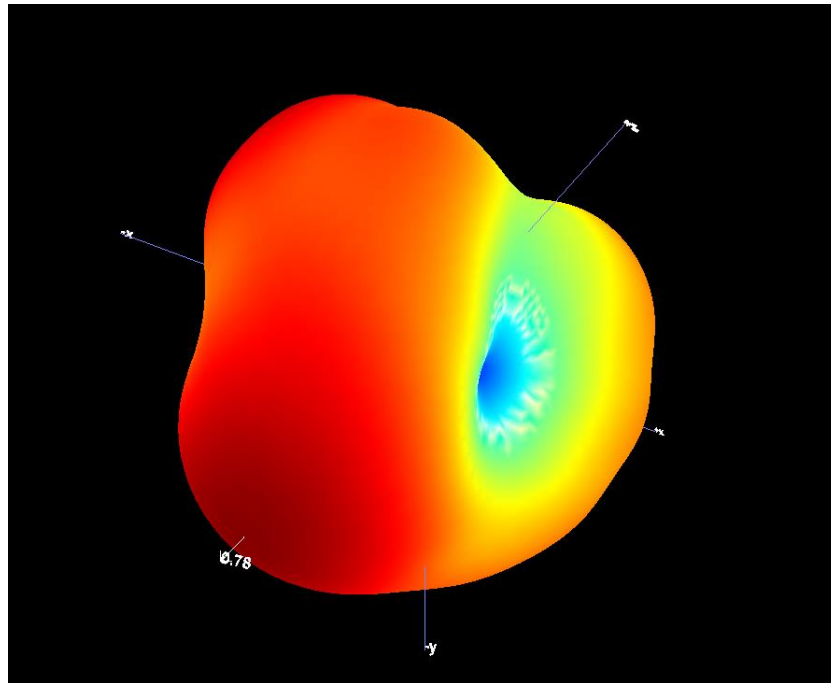
Frequency	SWR
2400MHz	1.78
2450MHz	1.84
2500MHz	1.92



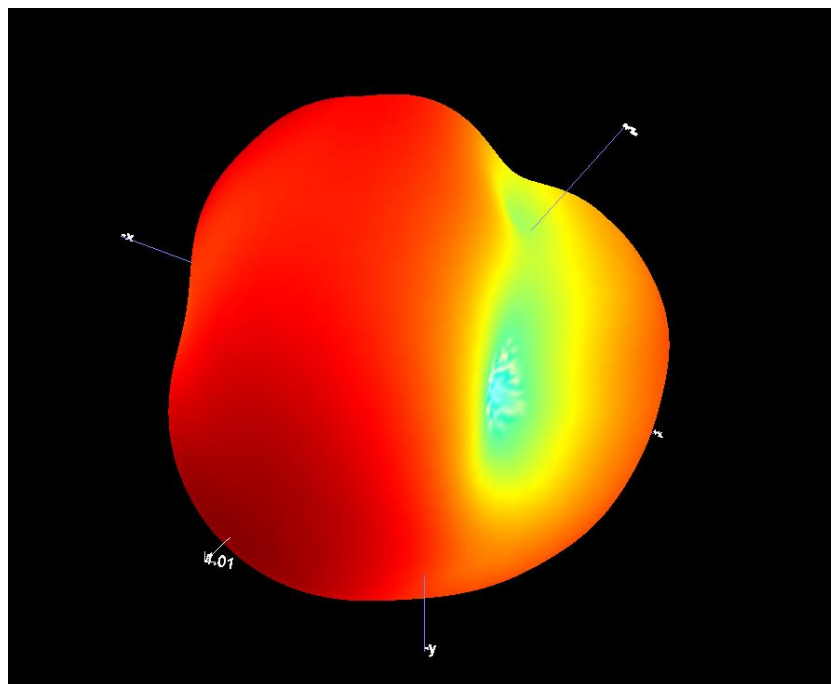
ANNEX B RADIATION PATTERN

B.1 3D Pattern

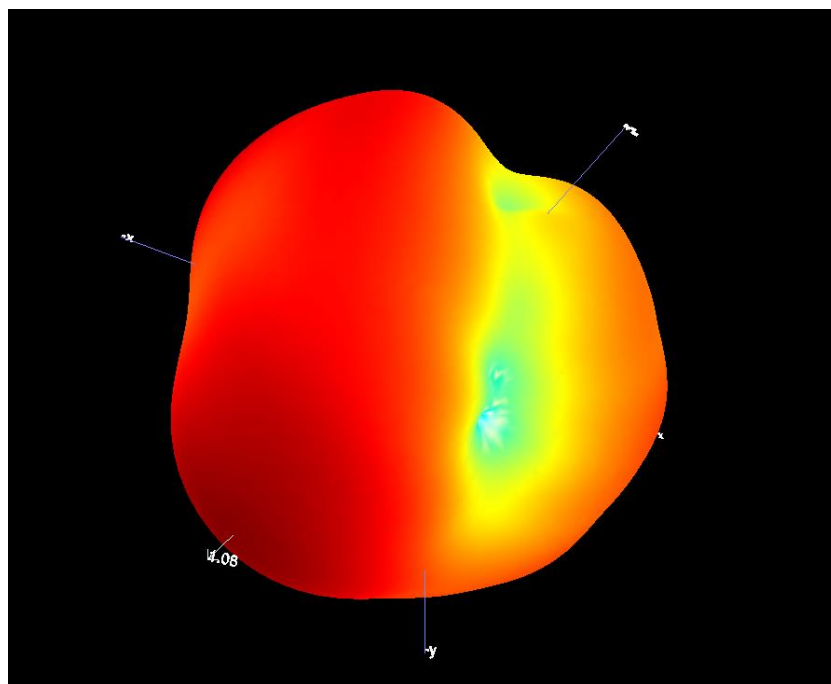
B1.1 3D Pattern for 2400MHz



B1.2 3D Pattern for 2450MHz

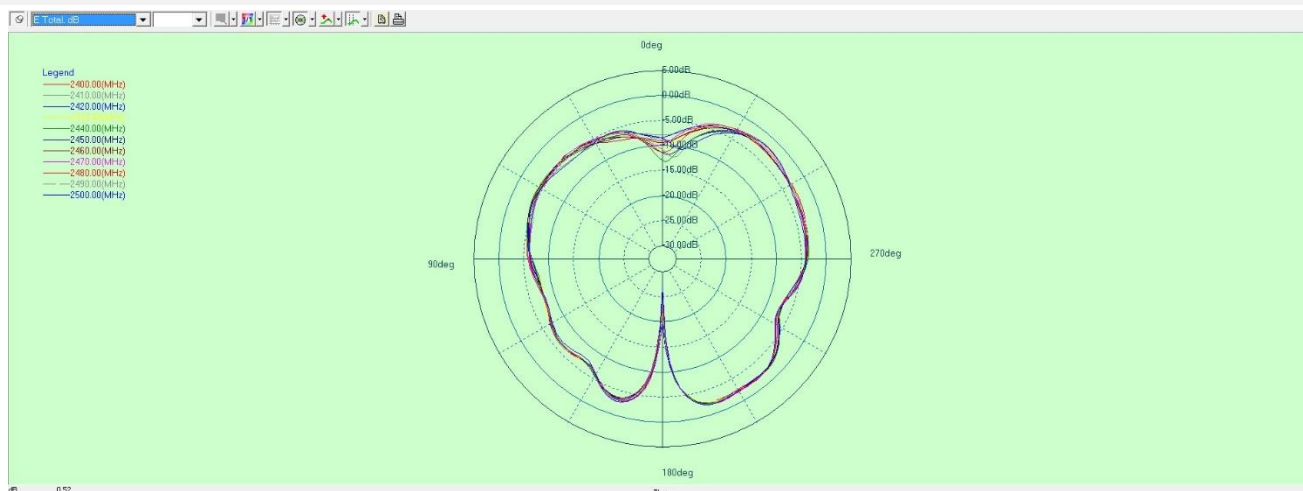


B1.3 3D Pattern for 2500MHz

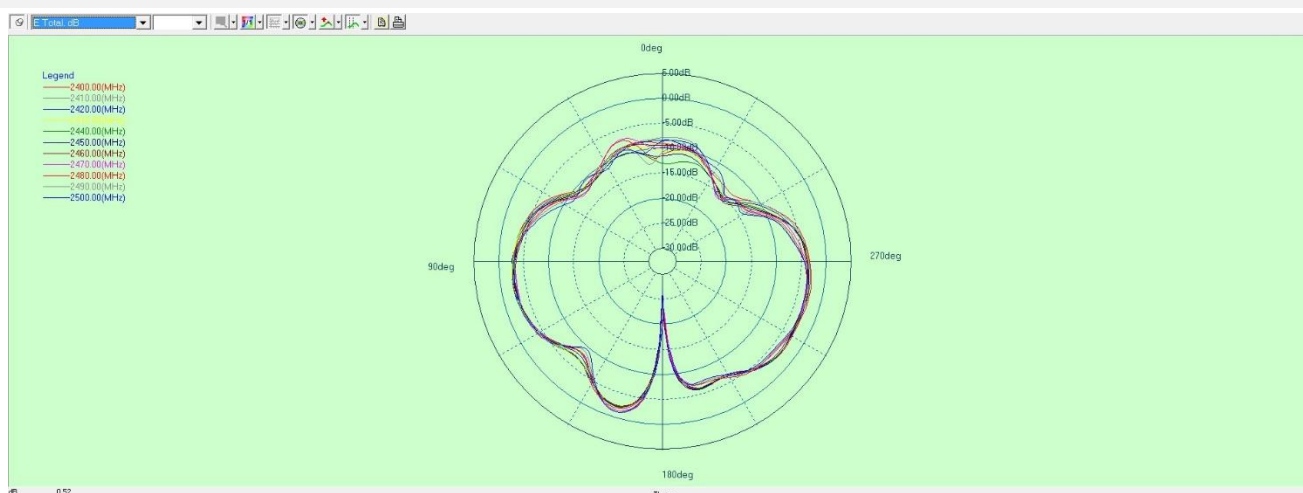


B.2 1D Radiation Pattern

B2.1 PHI=0



B2.2 PHI=90



B2.3 THETA=90



ANNEX C TEST SETUP PHOTOS

Please refer the document “BL-SZ2411346-AO.PDF”.

ANNEX D EUT PHOTO

Please refer the document “BL-SZ2411346-AA.PDF”.

Statement

1. The laboratory guarantees the scientificity, accuracy and impartiality of the test, and is responsible for all the information in the report, except the information provided by the customer. The customer is responsible for the impact of the information provided on the validity of the results.
2. The report without China inspection body and laboratory Mandatory Approval (CMA) mark has no effect of proving to the society.
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5. The test data and results are only valid for the tested samples provided by the customer.
6. This report shall not be partially reproduced without the written permission of the laboratory.
7. Any objection shall be raised to the laboratory within 30 days after receiving the report.

--END OF REPORT--